Search Notes					

Application No.	Applicant(s)
09/966,397	BLEMEL, KENNETH G.
Examiner	Art Unit
Inffray B Most	2857

			
	SEAR	CHED	
Class	Subclass	Date	Examiner
702	34-36 182,183	8/4/2004	JRW
702	188,189	8/4/2004	JRW
324	512,539	8/4/2004	JRW
324	541	8/4/2004	JRW
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INT	ERFERENC	E SEARCH	HED
Class	Subclass	Date	Examiner
		 	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Inventor Search Online Search	8/4/2004	JRW
((monitor or monitors or monitoring or monitored or diagnose or diagnosing or diagnoses or diagnosis or diagnosed or diagnost	8/4/2004	JRW
ic or diagnostics) and (conduit or conduits)).ti.	8/4/2004	JRW
(rate or rates) with (change or changes or changing or changed or degrade or degrading or degrades or degraded or degradation	8/4/2004	JRW
or degradations) with (remaining or remain or remains) with (life)	8/4/2004	JRW
((fiber or fibre) adj (optic or optics or optical)).ti. and ((fiber or fibre) adj (optic or optics or optical))with (silica)	8/4/2004	JRW
with glass	8/4/2004	JRW